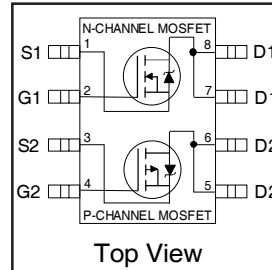


# IRF7105QPbF

HEXFET® Power MOSFET

- Advanced Process Technology
- Ultra Low On-Resistance
- Dual N and P Channel MOSFET
- Surface Mount
- Available in Tape & Reel
- 150°C Operating Temperature
- Automotive [Q101] Qualified
- Lead-Free

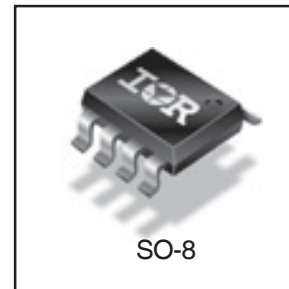


	N-Ch	P-Ch
$V_{DSS}$	25V	-25V
$R_{DS(on)}$	0.10Ω	0.25Ω
$I_D$	3.5A	-2.3A

## Description

Specifically designed for Automotive applications, these HEXFET® Power MOSFET's in a Dual SO-8 package utilize the latest processing techniques to achieve extremely low on-resistance per silicon area. Additional features of these Automotive qualified HEXFET Power MOSFET's are a 150°C junction operating temperature, fast switching speed and improved repetitive avalanche rating. These benefits combine to make this design an extremely efficient and reliable device for use in Automotive applications and a wide variety of other applications.

The efficient SO-8 package provides enhanced thermal characteristics and dual MOSFET die capability making it ideal in a variety of power applications. This dual, surface mount SO-8 can dramatically reduce board space and is also available in Tape & Reel.



## Absolute Maximum Ratings

	Parameter	Max.		Units
		N-Channel	P-Channel	
$I_D @ T_A = 25^\circ\text{C}$	Continuous Drain Current, $V_{GS} @ 10\text{V}$	3.5	-2.3	A
$I_D @ T_A = 70^\circ\text{C}$	Continuous Drain Current, $V_{GS} @ 10\text{V}$	2.8	-1.8	
$I_{DM}$	Pulsed Drain Current ①	14	-10	
$P_D @ T_C = 25^\circ\text{C}$	Power Dissipation	2.0		W
	Linear Derating Factor	0.016		W/°C
$V_{GS}$	Gate-to-Source Voltage	$\pm 20$		V
$dv/dt$	Peak Diode Recovery $dv/dt$ ②	3.0	-3.0	V/nS
$T_J, T_{STG}$	Junction and Storage Temperature Range	-55 to + 150		°C

## Thermal Resistance Ratings

	Parameter	Min.	Typ.	Max.	Units
$R_{\theta JA}$	Maximum Junction-to-Ambient ④	—	—	62.5	°C/W

# IRF7105QPbF

International  
 Rectifier

## Electrical Characteristics @ T<sub>J</sub> = 25°C (unless otherwise specified)

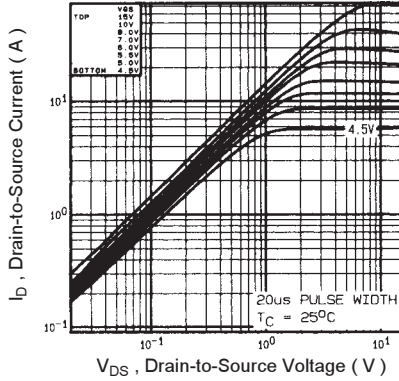
Parameter	Description		Min.	Typ.	Max.	Units	Conditions
V <sub>(BR)DSS</sub>	Drain-to-Source Breakdown Voltage	N-Ch	25	—	—	V	V <sub>GS</sub> = 0V, I <sub>D</sub> = 250μA
		P-Ch	-25	—	—		V <sub>GS</sub> = 0V, I <sub>D</sub> = -250μA
ΔV <sub>(BR)DSS</sub> /ΔT <sub>J</sub>	Breakdown Voltage Temp. Coefficient	N-Ch	—	0.030	—	V/°C	Reference to 25°C, I <sub>D</sub> = 1mA
		P-Ch	—	-0.015	—		Reference to 25°C, I <sub>D</sub> = -1mA
R <sub>DS(ON)</sub>	Static Drain-to-Source On-Resistance	N-Ch	—	0.083	0.10	Ω	V <sub>GS</sub> = 10V, I <sub>D</sub> = 1.0A ③
		N-Ch	—	0.14	0.16		V <sub>GS</sub> = 4.5V, I <sub>D</sub> = 0.50A ③
		P-Ch	—	0.16	0.25		V <sub>GS</sub> = -10V, I <sub>D</sub> = -1.0A ③
		P-Ch	—	0.30	0.40		V <sub>GS</sub> = -4.5V, I <sub>D</sub> = -0.50A ③
V <sub>GS(th)</sub>	Gate Threshold Voltage	N-Ch	1.0	—	3.0	V	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 250μA
		P-Ch	-1.0	—	-3.0		V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = -250μA
g <sub>fs</sub>	Forward Transconductance	N-Ch	—	4.3	—	S	V <sub>DS</sub> = 15V, I <sub>D</sub> = 3.5A ③
		P-Ch	—	3.1	—		V <sub>DS</sub> = -15V, I <sub>D</sub> = -3.5A ③
I <sub>DSS</sub>	Drain-to-Source Leakage Current	N-Ch	—	—	2.0	μA	V <sub>DS</sub> = 20V, V <sub>GS</sub> = 0V
		P-Ch	—	—	-2.0		V <sub>DS</sub> = -20V, V <sub>GS</sub> = 0V
		N-Ch	—	—	25		V <sub>DS</sub> = 20V, V <sub>GS</sub> = 0V, T <sub>J</sub> = 55°C
		P-Ch	—	—	-25		V <sub>DS</sub> = -20V, V <sub>GS</sub> = 0V, T <sub>J</sub> = 55°C
I <sub>GSS</sub>	Gate-to-Source Forward Leakage	N-P	—	—	±100		V <sub>GS</sub> = ±20V
Q <sub>g</sub>	Total Gate Charge	N-Ch	—	9.4	27	nC	N-Channel I <sub>D</sub> = 2.3A, V <sub>DS</sub> = 12.5V, V <sub>GS</sub> = 10V ③
P-Ch	—	10	25				
Q <sub>gs</sub>	Gate-to-Source Charge	N-Ch	—	1.7	—	nC	P-Channel I <sub>D</sub> = -2.3A, V <sub>DS</sub> = -12.5V, V <sub>GS</sub> = -10V
P-Ch	—	1.9	—				
Q <sub>gd</sub>	Gate-to-Drain ("Miller") Charge	N-Ch	—	3.1	—	nC	
P-Ch	—	2.8	—				
t <sub>d(on)</sub>	Turn-On Delay Time	N-Ch	—	7.0	20	ns	N-Channel V <sub>DD</sub> = 25V, I <sub>D</sub> = 1.0A, R <sub>G</sub> = 6.0Ω, R <sub>D</sub> = 25Ω ③
P-Ch	—	12	40				
t <sub>r</sub>	Rise Time	N-Ch	—	9.0	20	ns	P-Channel V <sub>DD</sub> = -25V, I <sub>D</sub> = -1.0A, R <sub>G</sub> = 6.0Ω, R <sub>D</sub> = 25Ω ③
P-Ch	—	13	40				
t <sub>d(off)</sub>	Turn-Off Delay Time	N-Ch	—	45	90	ns	
P-Ch	—	45	90				
t <sub>f</sub>	Fall Time	N-Ch	—	25	50	ns	
P-Ch	—	37	50				
L <sub>D</sub>	Internal Drain Inductance	N-P	—	4.0	—	nH	Between lead, 6mm (0.25in.) from package and center of die contact
L <sub>S</sub>	Internal Source Inductance	N-P	—	6.0	—		
C <sub>iss</sub>	Input Capacitance	N-Ch	—	330	—	pF	N-Channel V <sub>GS</sub> = 0V, V <sub>DS</sub> = 15V, f = 1.0MHz
		P-Ch	—	290	—		
C <sub>oss</sub>	Output Capacitance	N-Ch	—	250	—	pF	P-Channel V <sub>GS</sub> = 0V, V <sub>DS</sub> = -15V, f = 1.0MHz
		P-Ch	—	210	—		
C <sub>riss</sub>	Reverse Transfer Capacitance	N-Ch	—	61	—	pF	
P-Ch	—	67	—				

## Source-Drain Ratings and Characteristics

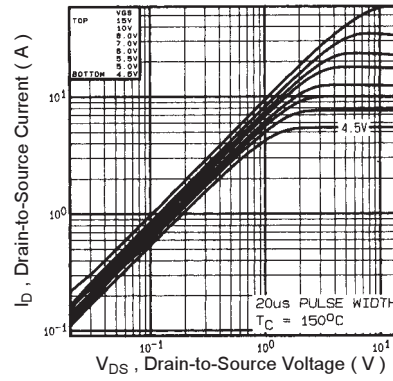
Parameter	Description		Min.	Typ.	Max.	Units	Conditions	
I <sub>S</sub>	Continuous Source Current (Body Diode)	N-Ch	—	—	2.0	A		
P-Ch	—	—	—	-2.0				
I <sub>SM</sub>	Pulsed Source Current (Body Diode) ①	N-Ch	—	—	14	A		
		P-Ch	—	—	-9.2			
V <sub>SD</sub>	Diode Forward Voltage	N-Ch	—	—	1.2	V	T <sub>J</sub> = 25°C, I <sub>S</sub> = 1.3A, V <sub>GS</sub> = 0V ③	
		P-Ch	—	—	-1.2		T <sub>J</sub> = 25°C, I <sub>S</sub> = -1.3A, V <sub>GS</sub> = 0V ③	
t <sub>rr</sub>	Reverse Recovery Time	N-Ch	—	36	54	ns	N-Channel T <sub>J</sub> = 25°C, I <sub>F</sub> = 1.3A, di/dt = 100A/μs ③	
P-Ch	—	69	100					
Q <sub>rr</sub>	Reverse Recovery Charge	N-Ch	—	41	75	nC	P-Channel T <sub>J</sub> = 25°C, I <sub>F</sub> = -1.3A, di/dt = 100A/μs ③	
P-Ch	—	90	180					
t <sub>on</sub>	Forward Turn-On Time	N-P	Intrinsic turn-on time is negligible (turn-on is dominated by L <sub>S</sub> +L <sub>D</sub> )					

### Notes:

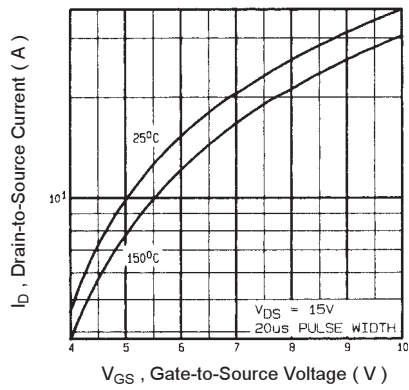
- ① Repetitive rating; pulse width limited by max. junction temperature.
- ② N-Channel I<sub>SD</sub> ≤ 3.5A, di/dt ≤ 90A/μs, V<sub>DD</sub> ≤ V<sub>(BR)DSS</sub>, T<sub>J</sub> ≤ 150°C  
P-Channel I<sub>SD</sub> ≤ -2.3A, di/dt ≤ 90A/μs, V<sub>DD</sub> ≤ V<sub>(BR)DSS</sub>, T<sub>J</sub> ≤ 150°C
- ③ Pulse width ≤ 300μs; duty cycle ≤ 2%.
- ④ Surface mounted on FR-4 board, t ≤ 10sec.



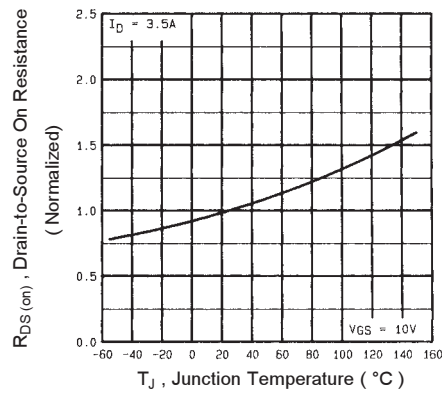
**Fig 1.** Typical Output Characteristics



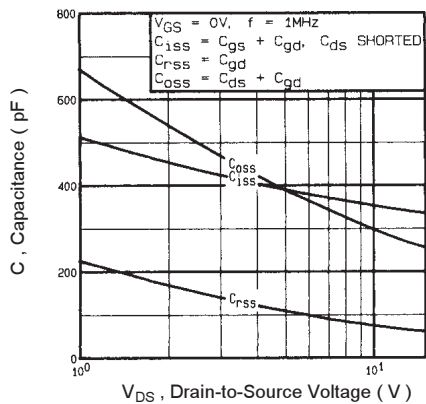
**Fig 2.** Typical Output Characteristics



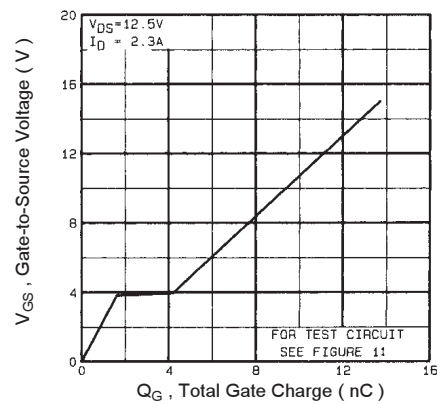
**Fig 3.** Typical Transfer Characteristics



**Fig 4.** Normalized On-Resistance Vs. Temperature



**Fig 5.** Typical Capacitance Vs. Drain-to-Source Voltage

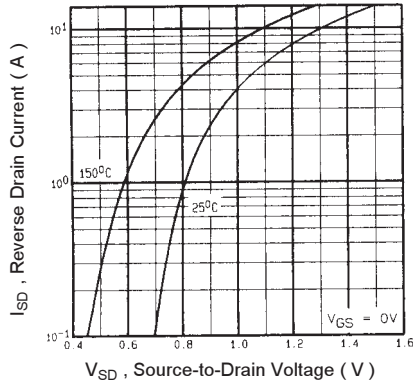


**Fig 6.** Typical Gate Charge Vs. Gate-to-Source Voltage

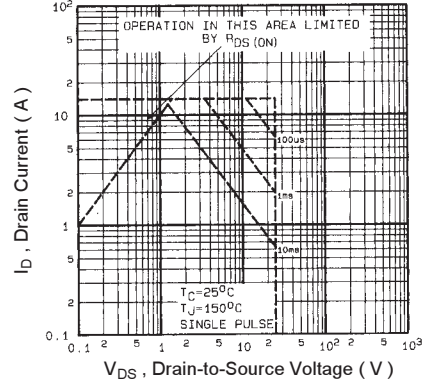
# IRF7105QPbF

N-Channel

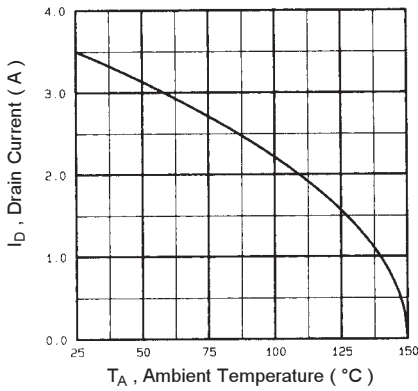
International  
**IR** Rectifier



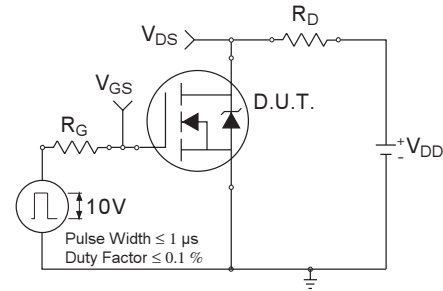
**Fig 7.** Typical Source-Drain Diode Forward Voltage



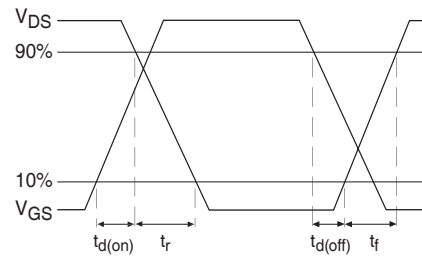
**Fig 8.** Maximum Safe Operating Area



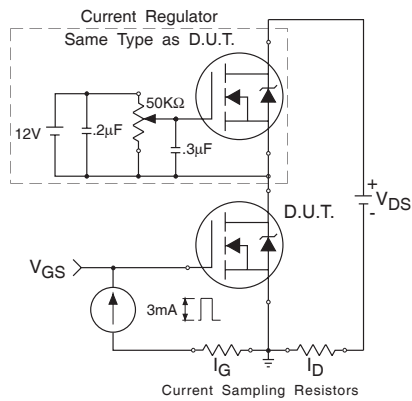
**Fig 9.** Maximum Drain Current Vs. Ambient Temperature



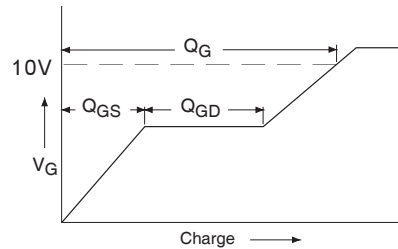
**Fig 10a.** Switching Time Test Circuit



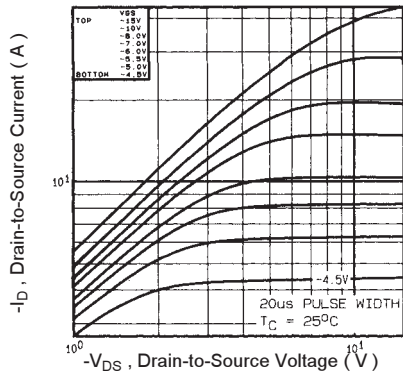
**Fig 10b.** Switching Time Waveforms



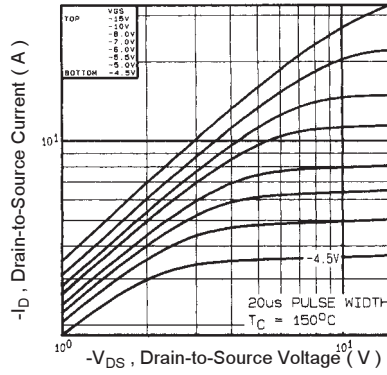
**Fig 11a.** Gate Charge Test Circuit



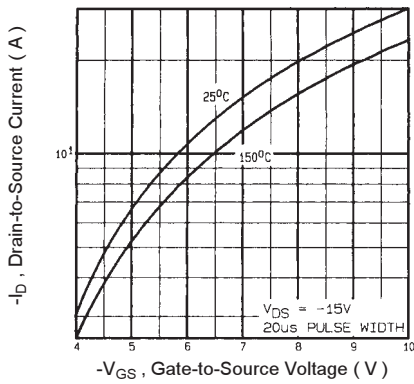
**Fig 11b.** Basic Gate Charge Waveform



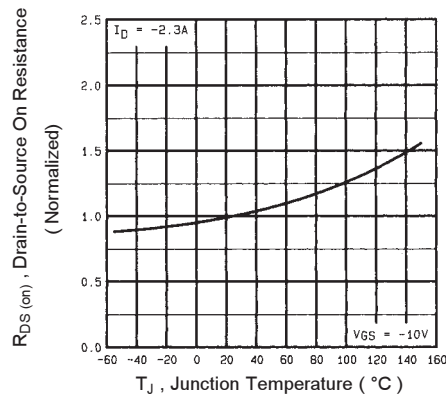
**Fig 12.** Typical Output Characteristics



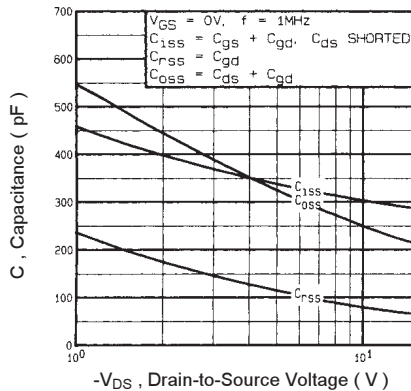
**Fig 13.** Typical Output Characteristics



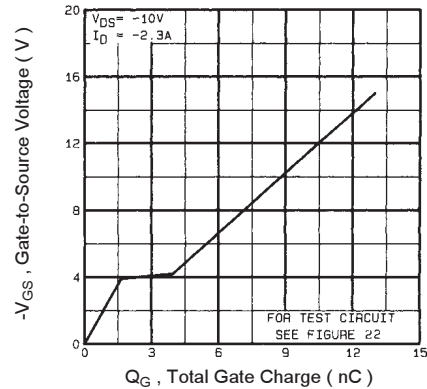
**Fig 14.** Typical Transfer Characteristics



**Fig 15.** Normalized On-Resistance Vs. Temperature



**Fig 16.** Typical Capacitance Vs. Drain-to-Source Voltage

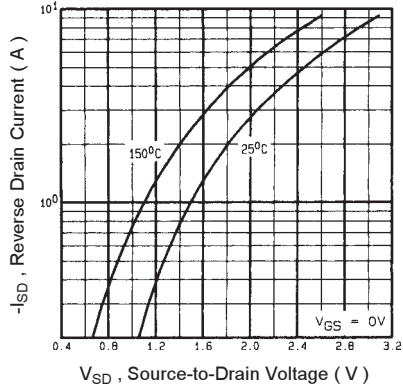


**Fig 17.** Typical Gate Charge Vs. Gate-to-Source Voltage

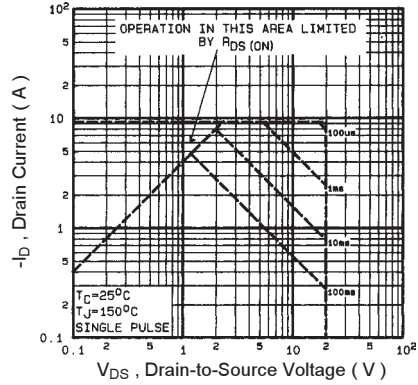
# IRF7105QPbF

P-Channel

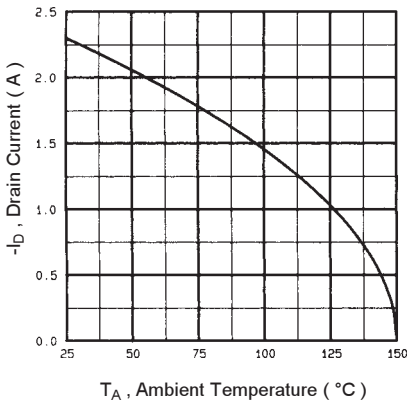
International  
**IR** Rectifier



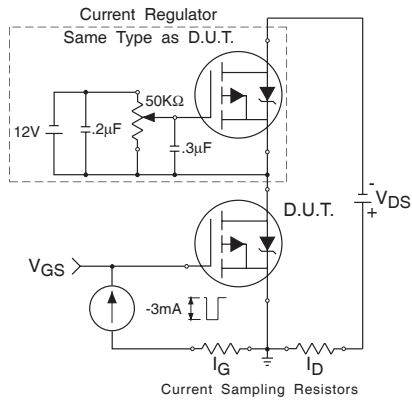
**Fig 18.** Typical Source-Drain Diode Forward Voltage



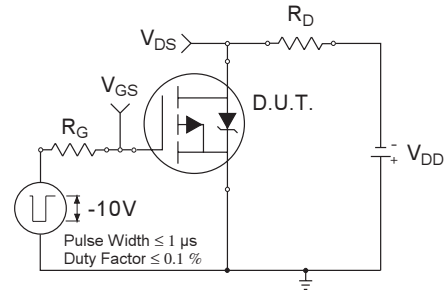
**Fig 19.** Maximum Safe Operating Area



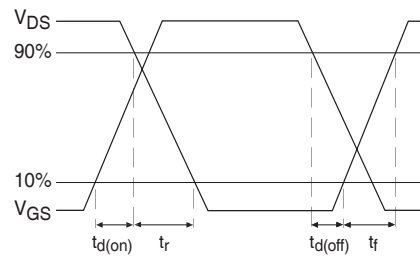
**Fig 20.** Maximum Drain Current Vs. Ambient Temperature



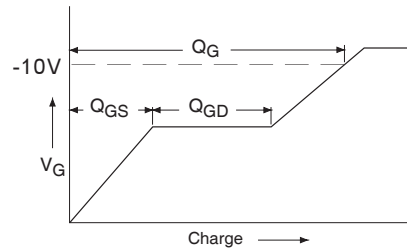
**Fig 22a.** Gate Charge Test Circuit



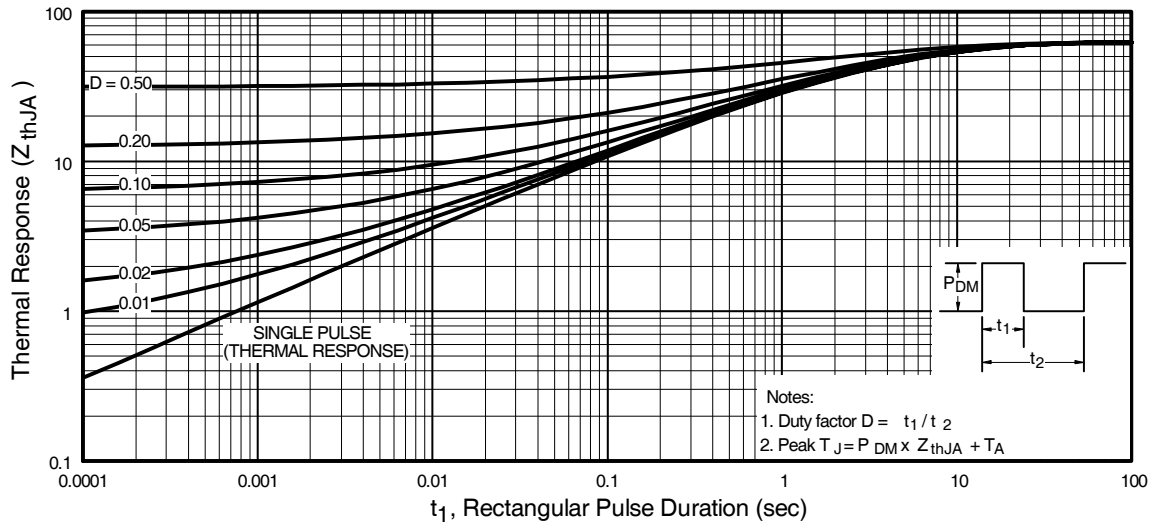
**Fig 21a.** Switching Time Test Circuit



**Fig 21b.** Switching Time Waveforms

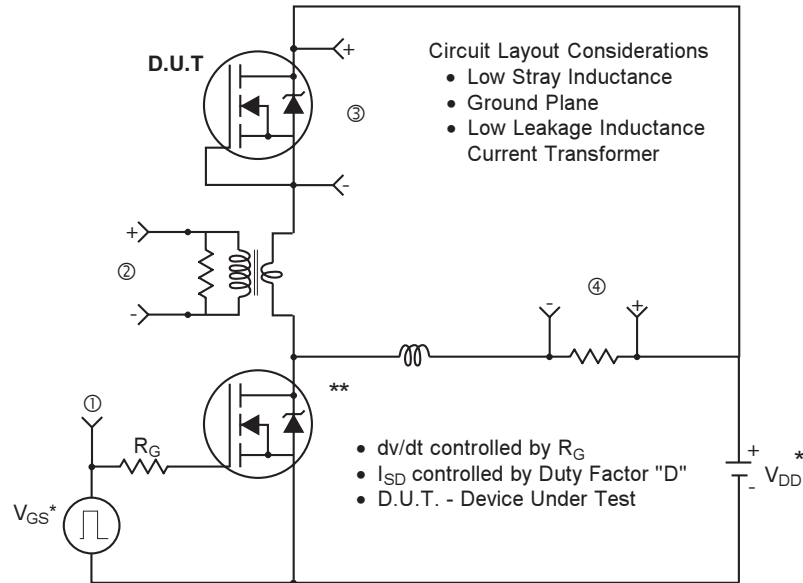


**Fig 22b.** Basic Gate Charge Waveform



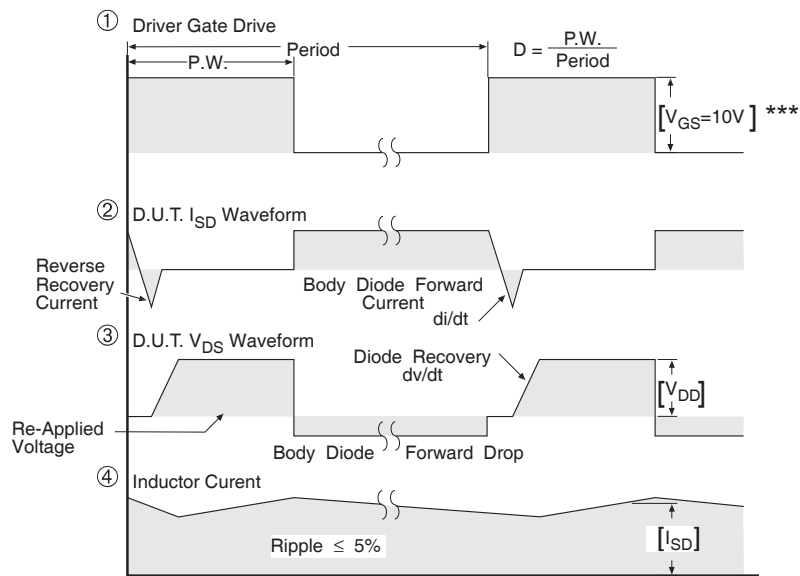
**Fig 23.** Maximum Effective Transient Thermal Impedance, Junction-to-Ambient

## Peak Diode Recovery dv/dt Test Circuit



\* Reverse Polarity for P-Channel

\*\* Use P-Channel Driver for P-Channel Measurements



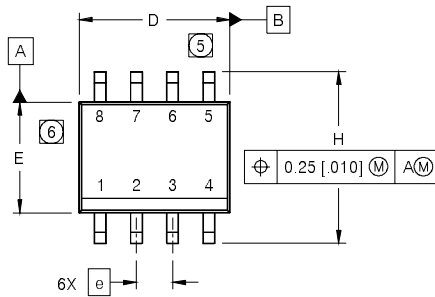
\*\*\*  $V_{GS} = 5.0V$  for Logic Level and 3V Drive Devices

**Fig 24.** For N and P Channel HEXFETS

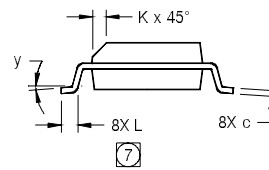
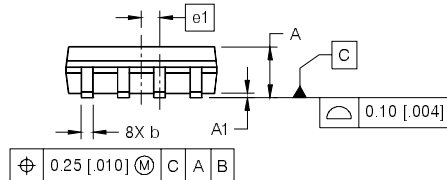


## SO-8 Package Outline

Dimensions are shown in millimeters (inches)



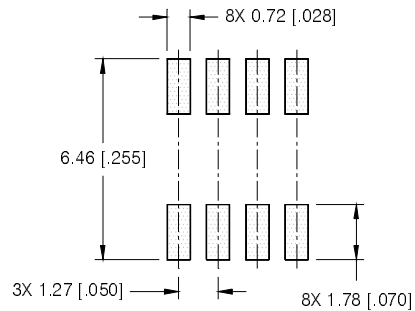
DIM	INCHES		MILLIMETERS	
	MIN	MAX	MIN	MAX
A	.0532	.0688	1.35	1.75
A1	.0040	.0098	0.10	0.25
b	.013	.020	0.33	0.51
c	.0075	.0098	0.19	0.25
D	.189	.1968	4.80	5.00
E	.1497	.1574	3.80	4.00
e	.050 BASIC		1.27 BASIC	
e1	.025 BASIC		0.635 BASIC	
H	.2284	.2440	5.80	6.20
K	.0099	.0196	0.25	0.50
L	.016	.050	0.40	1.27
y	0°	8°	0°	8°



**NOTES:**

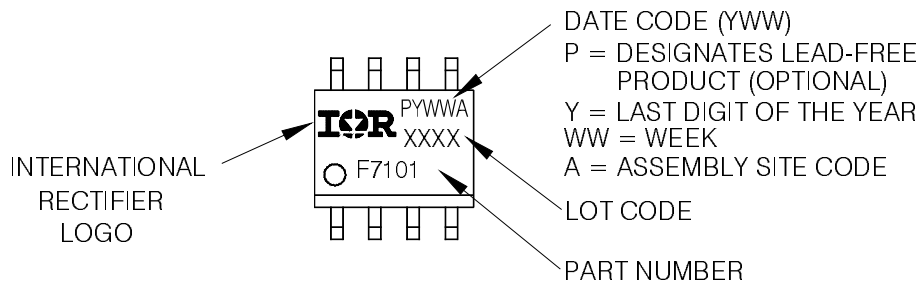
1. DIMENSIONING & TOLERANCING PER ASME Y14.5M-1994.
2. CONTROLLING DIMENSION: MILLIMETER
3. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].
4. OUTLINE CONFORMS TO JEDEC OUTLINE MS-012AA.
- ⑤ DIMENSION DOES NOT INCLUDE MOLD PROTRUSIONS. MOLD PROTRUSIONS NOT TO EXCEED 0.15 [0.006].
- ⑥ DIMENSION DOES NOT INCLUDE MOLD PROTRUSIONS. MOLD PROTRUSIONS NOT TO EXCEED 0.25 [0.010].
- ⑦ DIMENSION IS THE LENGTH OF LEAD FOR SOLDERING TO A SUBSTRATE.

**FOOTPRINT**



## SO-8 Part Marking

EXAMPLE: THIS IS AN IRF7101 (MOSFET)



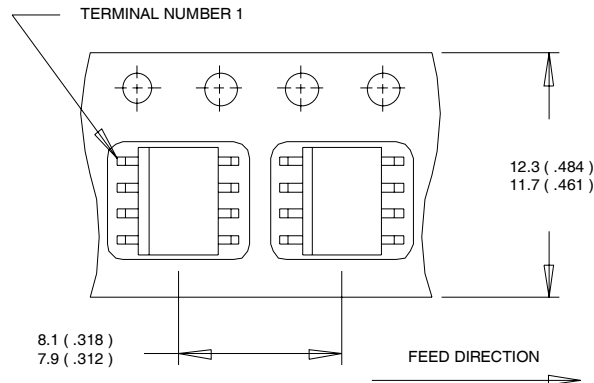
**Note:** For the most current drawing please refer to IR website at <http://www.irf.com/package/>

# IRF7105QPbF

International  
**IR** Rectifier

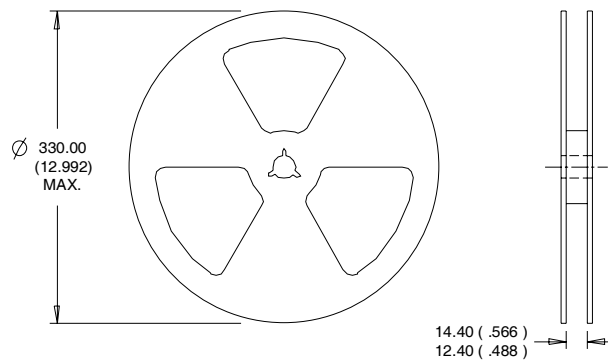
## SO-8 Tape and Reel

Dimensions are shown in millimeters (inches)



### NOTES:

1. CONTROLLING DIMENSION : MILLIMETER.
2. ALL DIMENSIONS ARE SHOWN IN MILLIMETERS(INCHES).
3. OUTLINE CONFORMS TO EIA-481 & EIA-541.



### NOTES :

1. CONTROLLING DIMENSION : MILLIMETER.
2. OUTLINE CONFORMS TO EIA-481 & EIA-541.

**Note:** For the most current drawing please refer to IR website at <http://www.irf.com/package/>

Data and specifications subject to change without notice.  
This product has been designed and qualified for the Automotive [Q101] market.  
Qualification Standards can be found on IR's Web site.

International  
**IR** Rectifier

**IR WORLD HEADQUARTERS:** 233 Kansas St., El Segundo, California 90245, USA Tel: (310) 252-7105  
TAC Fax: (310) 252-7903

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